

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/540,973	TANABE, AKIRA	
	Examiner Suchin Parihar	Art Unit 2825	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,295,630	09-2001	Tamegaya, Yukio	716/4
*	B	US-6,734,501	05-2004	Sugano et al.	257/347
*	C	US-5,453,923	09-1995	Scalais et al.	363/53
*	D	US-5,990,741	11-1999	Yamamoto et al.	330/253
*	E	US-7,132,703	11-2006	Hikita et al.	257/280
*	F	US-2004/0133862	07-2004	Naruta et al.	716/004
*	G	US-5,917,333	06-1999	Ogawa, Hisao	324/769
*	H	US-4,361,797	11-1982	Kojima et al.	323/316
*	I	US-5,940,261	08-1999	Bagna et al.	361/150
*	J	US-5,283,726	02-1994	Wilkerson, Alan W.	363/41
*	K	US-2004/0189388	09-2004	Nguyen et al.	330/254
*	L	US-6,991,948	01-2006	Hillard, Robert J.	438/17
*	M	US-4,241,316	12-1980	Knapp, Richard P.	330/277

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.